

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VCX74FT, TC74VCX74FK

Low-Voltage Dual D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

The TC74VCX74FT/FK is a high-performance CMOS D-type flip-flop which is guaranteed to operate from 1.2-V to 3.6-V. Designed for use in 1.5V, 1.8V, 2.5V or 3.3V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

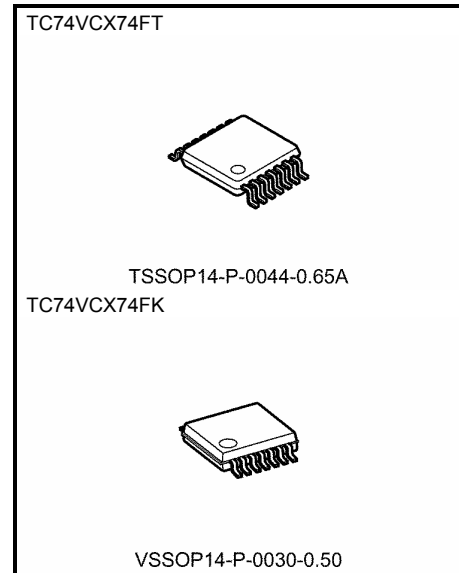
It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

The signal level applied to the D INPUT is transferred to Q OUTPUT during the positive going transition of the CK pulse. $\overline{\text{CLR}}$ and $\overline{\text{PR}}$ are independent of the CK and are accomplished by setting the appropriate input low.

All inputs are equipped with protection circuits against static discharge.

Features

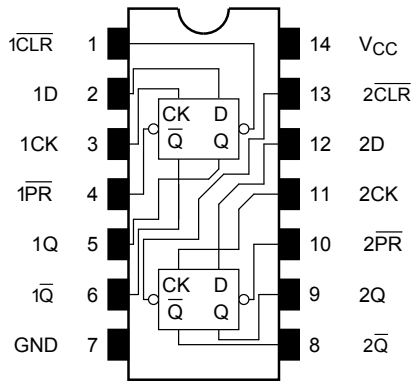
- Low-voltage operation: $V_{CC} = 1.2\sim 3.6\text{ V}$
- High-speed operation: $t_{pd} = 3.5\text{ ns (max) (}V_{CC} = 3.0\sim 3.6\text{ V)}$
 : $t_{pd} = 4.6\text{ ns (max) (}V_{CC} = 2.3\sim 2.7\text{ V)}$
 : $t_{pd} = 9.2\text{ ns (max) (}V_{CC} = 1.65\sim 1.95\text{ V)}$
 : $t_{pd} = 18.4\text{ ns (max) (}V_{CC} = 1.4\sim 1.6\text{ V)}$
 : $t_{pd} = 46.0\text{ ns (max) (}V_{CC} = 1.2\text{ V)}$
- Output current: $I_{OH}/I_{OL} = \pm 24\text{ mA (min) (}V_{CC} = 3.0\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 18\text{ mA (min) (}V_{CC} = 2.3\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 6\text{ mA (min) (}V_{CC} = 1.65\text{ V)}$
 : $I_{OH}/I_{OL} = \pm 2\text{ mA (min) (}V_{CC} = 1.4\text{ V)}$
- Latch-up performance: -300 mA
- ESD performance: Machine model $\geq \pm 200\text{ V}$
 Human body model $\geq \pm 2000\text{ V}$
- Package: TSSOP and VSSOP (US)
- Power-down protection provided on all inputs and outputs



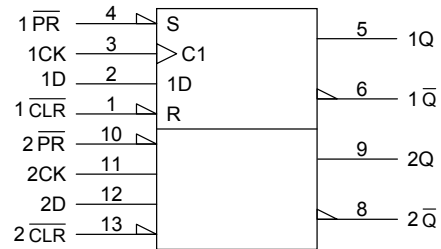
Weight

TSSOP14-P-0044-0.65A	: 0.06 g (typ.)
VSSOP14-P-0030-0.50	: 0.02 g (typ.)

Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Inputs				Outputs		Function
CLR	PR	D	CK	Q	Q̄	
L	H	X	X	L	H	Clear
H	L	X	X	H	L	Preset
L	L	X	X	H	H	—
H	H	L	↑	L	H	—
H	H	H	↑	H	L	—
H	H	X	↓	Q _n	Q̄ _n	No change

X: Don't care

Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5~4.6	V
DC input voltage	V _{IN}	-0.5~4.6	V
DC output voltage	V _{OUT}	-0.5~4.6 (Note 2)	V
		-0.5~V _{CC} + 0.5 (Note 3)	
Input diode current	I _{IK}	-50	mA
Output diode current	I _{OK}	±50 (Note 4)	mA
DC output current	I _{OUT}	±50	mA
Power dissipation	P _D	180	mW
DC V _{CC} /ground current	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: V_{CC} = 0 V

Note 3: High or low state. I_{OUT} absolute maximum rating must be observed.

Note 4: V_{OUT} < GND, V_{OUT} > V_{CC}

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	1.2~3.6	V
Input voltage	V_{IN}	-0.3~3.6	V
Output voltage	V_{OUT}	0~3.6 (Note 2)	V
		0~ V_{CC} (Note 3)	
Output current	I_{OH}/I_{OL}	± 24 (Note 4)	mA
		± 18 (Note 5)	
		± 6 (Note 6)	
		± 2 (Note 7)	
Operating temperature	T_{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either V_{CC} or GND.

Note 2: $V_{CC} = 0$ V

Note 3: High or low state

Note 4: $V_{CC} = 3.0\sim 3.6$ V

Note 5: $V_{CC} = 2.3\sim 2.7$ V

Note 6: $V_{CC} = 1.65\sim 1.95$ V

Note 7: $V_{CC} = 1.4\sim 1.6$ V

Note 8: $V_{IN} = 0.8\sim 2.0$ V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics ($T_a = -40$ to 85°C , 2.7 V < $V_{CC} \leq 3.6$ V)

Characteristics		Symbol	Test Condition	V_{CC} (V)	Min	Max	Unit
Input voltage	H-level	V_{IH}	—	2.7~3.6	2.0	—	V
	L-level	V_{IL}	—	2.7~3.6	—	0.8	
Output voltage	H-level	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -100 \mu\text{A}$	2.7~3.6	$V_{CC} - 0.2$	V
				$I_{OH} = -12 \text{ mA}$	2.7	2.2	
				$I_{OH} = -18 \text{ mA}$	3.0	2.4	
				$I_{OH} = -24 \text{ mA}$	3.0	2.2	
	L-level	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 100 \mu\text{A}$	2.7~3.6	—	0.2
				$I_{OL} = 12 \text{ mA}$	2.7	—	0.4
				$I_{OL} = 18 \text{ mA}$	3.0	—	0.4
				$I_{OL} = 24 \text{ mA}$	3.0	—	0.55
Input leakage current		I_{IN}	$V_{IN} = 0$ to 3.6 V	2.7~3.6	—	± 5.0	μA
Power off leakage current		I_{OFF}	$V_{IN}, V_{OUT} = 0$ to 3.6 V	0	—	10.0	μA
Quiescent supply current		I_{CC}	$V_{IN} = V_{CC}$ or GND	2.7~3.6	—	20.0	μA
			$V_{CC} \leq V_{IN} \leq 3.6$ V	2.7~3.6	—	± 20.0	
Increase in I_{CC} per input		ΔI_{CC}	$V_{IH} = V_{CC} - 0.6$ V	2.7~3.6	—	750	

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ VCC ≤ 2.7 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		2.3~2.7	1.6	—	V
	L-level	V _{IL}	—		2.3~2.7	—	0.7	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	2.3~2.7	V _{CC} - 0.2	—	V
				I _{OH} = -6 mA	2.3	2.0	—	
				I _{OH} = -12 mA	2.3	1.8	—	
				I _{OH} = -18 mA	2.3	1.7	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	2.3~2.7	—	0.2	
				I _{OL} = 12 mA	2.3	—	0.4	
I _{OL} = 18 mA				2.3	—	0.6		
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		2.3~2.7	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		2.3~2.7	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		2.3~2.7	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.65 V ≤ VCC < 2.3 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.65~2.3	0.65 × V _{CC}	—	V
	L-level	V _{IL}	—		1.65~2.3	—	0.2 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.65~2.3	V _{CC} - 0.2	—	V
				I _{OH} = -6 mA	1.65	1.25	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.65~2.3	—	0.2	
				I _{OL} = 6 mA	1.65	—	0.3	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.65~2.3	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.65~2.3	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.65~2.3	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.4 V ≤ VCC < 1.65 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.4~1.65	0.65 × V _{CC}	—	V
	L-level	V _{IL}	—		1.4~1.65	—	0.05 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.4~1.65	V _{CC} - 0.2	—	V
				I _{OH} = -2 mA	1.4	1.05	—	
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.4~1.65	—	0.05	
				I _{OL} = 2 mA	1.4	—	0.35	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.4~1.65	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.4~1.65	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.4~1.65	—	±20.0	

DC Characteristics (Ta = -40 to 85°C, 1.2 V ≤ VCC < 1.4 V)

Characteristics		Symbol	Test Condition		VCC (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	—		1.2~1.4	0.8 × V _{CC}	—	V
	L-level	V _{IL}	—		1.2~1.4	—	0.05 × V _{CC}	
Output voltage	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.2	V _{CC} - 0.1	—	V
	L-level	V _{OL}	V _{IN} = V _{IH} or V _{IL}	I _{OL} = 100 μA	1.2	—	0.05	
Input leakage current		I _{IN}	V _{IN} = 0 to 3.6 V		1.2	—	±5.0	μA
Power-off leakage current		I _{OFF}	V _{IN} , V _{OUT} = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND		1.2	—	20.0	μA
			V _{CC} ≤ V _{IN} ≤ 3.6 V		1.2	—	±20.0	

AC Characteristics (Ta = -40 to 85°C, input: tr = tf = 2.0 ns) (Note)

Characteristics	Symbol	Test Condition	VCC (V)	Min	Max	Unit	
Maximum clock frequency	fmax	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	40	—	MHz
				1.5 ± 0.1	80	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	100	—	
				2.5 ± 0.2	200	—	
Propagation delay time (CK-Q, Q̄)	tpLH tpHL	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	3.0	46.0	ns
				1.5 ± 0.1	2.0	18.4	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.5	9.2	
				2.5 ± 0.2	0.8	4.6	
Propagation delay time (CLR̄, PR̄-Q, Q̄)	tpLH tpHL	Figure 1, Figure 4	CL = 15 pF, RL = 2 kΩ	1.2	3.0	46.0	ns
				1.5 ± 0.1	2.0	18.4	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.5	9.2	
				2.5 ± 0.2	0.8	4.6	
Minimum pulse width (CK)	tw(H) tw(L)	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	24	—	ns
				1.5 ± 0.1	8.0	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	4.0	—	
				2.5 ± 0.2	1.5	—	
Minimum pulse width (CLR̄, PR̄)	tw(L)	Figure 1, Figure 4	CL = 15 pF, RL = 2 kΩ	1.2	24	—	ns
				1.5 ± 0.1	8.0	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	4.0	—	
				2.5 ± 0.2	1.5	—	
Minimum set-up time	ts	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	20	—	ns
				1.5 ± 0.1	7.5	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	3.0	—	
				2.5 ± 0.2	1.5	—	
Minimum hold time	th	Figure 1, Figure 2	CL = 15 pF, RL = 2 kΩ	1.2	8.0	—	ns
				1.5 ± 0.1	3.0	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	1.0	—	
				2.5 ± 0.2	1.0	—	
Minimum removal time	trem	Figure 1, Figure 3	CL = 15 pF, RL = 2 kΩ	1.2	24	—	ns
				1.5 ± 0.1	8.0	—	
			CL = 30 pF, RL = 500 Ω	1.8 ± 0.15	3.0	—	
				2.5 ± 0.2	2.0	—	
			3.3 ± 0.3	1.5	—		

Note: For CL = 50 pF, add approximately 300 ps to the AC maximum specification.

Dynamic Switching Characteristics (Ta = 25°C, input: tr = tf = 2.0 ns, CL = 30 pF)

Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Quiet output maximum dynamic VOL	VOLP	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	0.8	
Quiet output minimum dynamic VOL	VOLV	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	-0.25	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	-0.6	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	-0.8	
Quiet output minimum dynamic VOH	VOHV	V _{IH} = 1.8 V, V _{IL} = 0 V (Note)	1.8	1.5	V
		V _{IH} = 2.5 V, V _{IL} = 0 V (Note)	2.5	1.9	
		V _{IH} = 3.3 V, V _{IL} = 0 V (Note)	3.3	2.2	

Note: Parameter guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

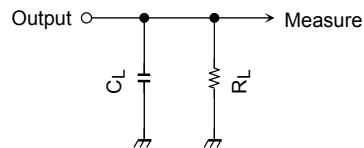
Characteristics	Symbol	Test Condition	VCC (V)	Typ.	Unit
Input capacitance	C _{IN}	—	1.8, 2.5, 3.3	6	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note)	1.8, 2.5, 3.3	20	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2 \text{ (per F/F)}$$

AC Test Circuit



Symbol	VCC	
		3.3 ± 0.3 V 2.5 ± 0.2 V 1.8 ± 0.15 V
R _L	500 Ω	2 kΩ
C _L	30 pF	15 pF

Figure 1

AC Waveform

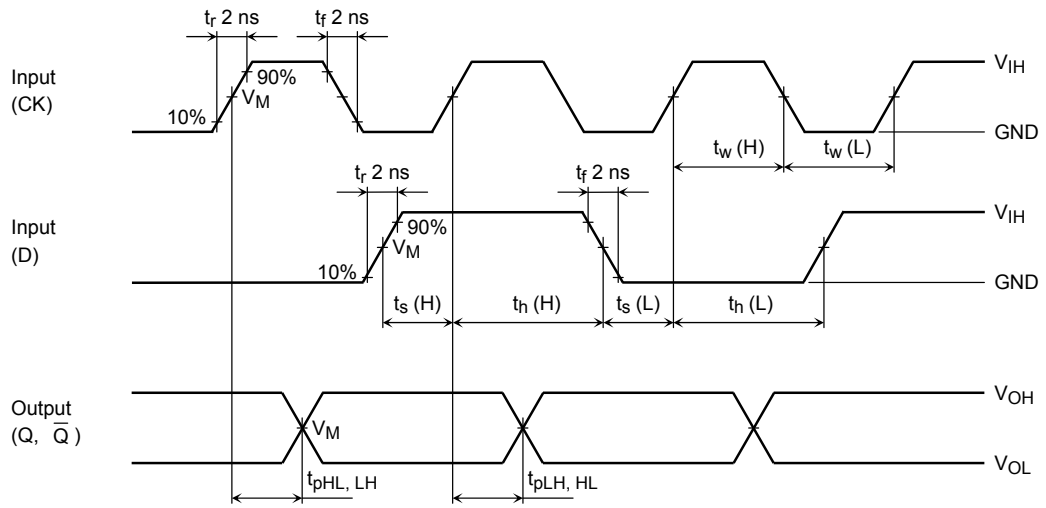


Figure 2 t_{pLH} , t_{pHL} , t_w , t_s , t_h

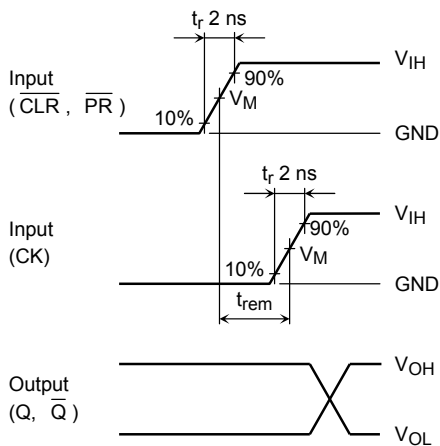


Figure 3 t_{rem}

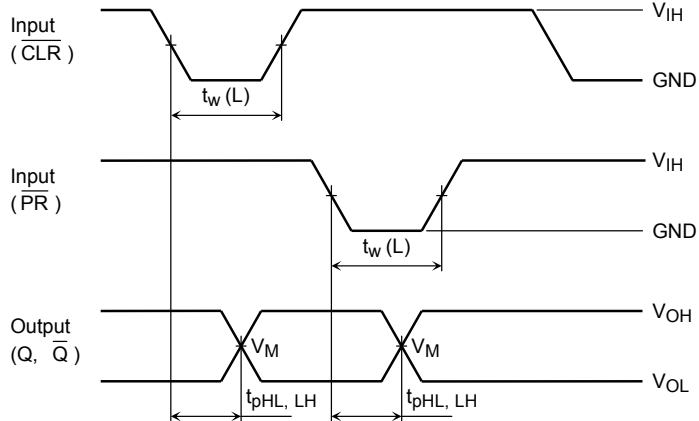


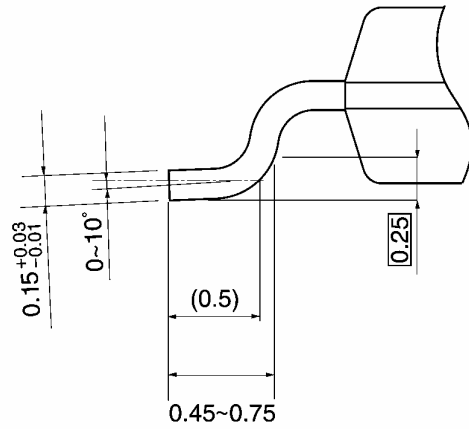
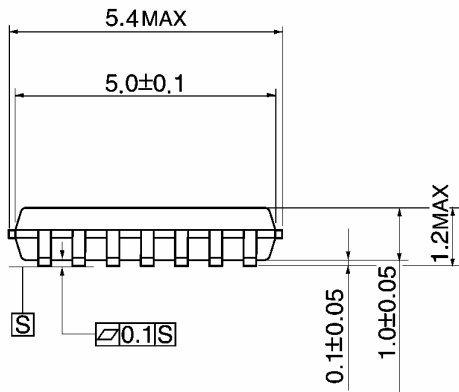
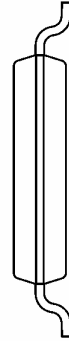
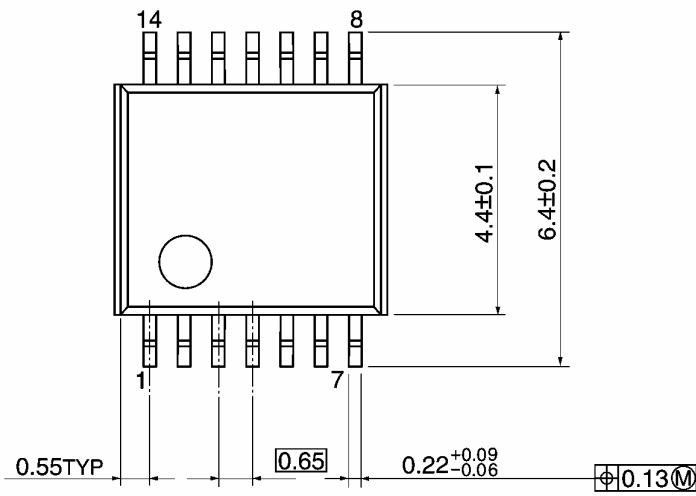
Figure 4 t_{pLH} , t_{pHL} , t_w

Symbol	V_{CC}				
	3.3 ± 0.3 V	2.5 ± 0.2 V	1.8 ± 0.15 V	1.5 ± 0.1 V	1.2 V
V_{IH}	2.7 V	V_{CC}	V_{CC}	V_{CC}	V_{CC}
V_M	1.5 V	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$	$V_{CC}/2$

Package Dimensions

TSSOP14-P-0044-0.65A

Unit: mm

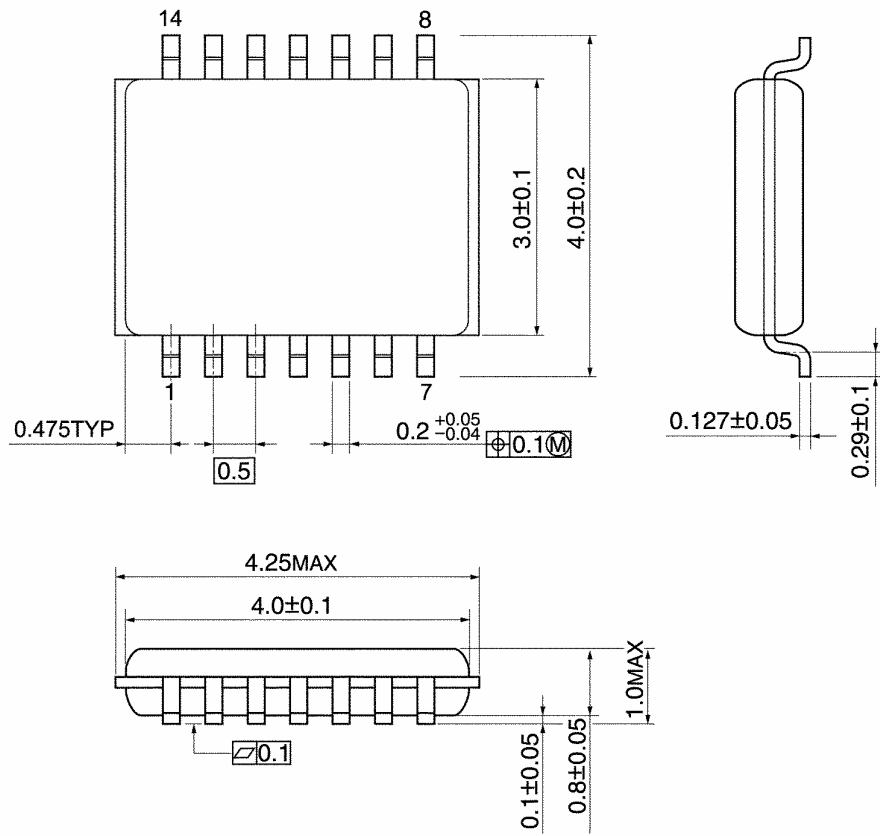


Weight: 0.06 g (typ.)

Package Dimensions

VSSOP14-P-0030-0.50

Unit: mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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